TPS7B88-Q1 500-mA, 40-V, Low-Dropout Regulator

1 Features

- AEC-Q100 qualified for automotive applications:
  - Temperature grade 1: –40°C to +125°C, T_A
  - Junction temperature: –40°C to +150°C, T_J
- Input voltage range: 3 V to 40 V (42 V max)
- Output voltage range: 3.3 V and 5 V (fixed)
- Maximum output current: 500 mA
- Output voltage accuracy: ±1.15% (max)
- Low dropout voltage:
  - 525 mV (max) at 450 mA
- Low quiescent current:
  - 17 µA (typ) at light loads
- Excellent line transient response:
  - ±2% V_{OUT} deviation during cold-crank
  - ±2% V_{OUT} deviation (1-V/µs V_{IN} slew rate)
- Stable with a 2.2-µF or larger capacitor
- Package 3-pin TO-252: ($R_{\theta JA}$): 30°C/W

2 Applications

- Reconfigurable instrument clusters
- Body control modules (BCM)
- Always-on battery-connected applications:
  - Automotive gateways
  - Remote keyless entries (RKE)

3 Description

The TPS7B88-Q1 is a low-dropout linear regulator designed to connect to the battery in automotive applications. The device has an input voltage range extending to 40 V, which allows the device to withstand transients (such as load dump) that are anticipated in automotive systems. With only a 17-µA quiescent current at light loads, the device is an optimal solution for powering always-on components such as microcontrollers (MCUs) and controller area network (CAN) transceivers in standby systems.

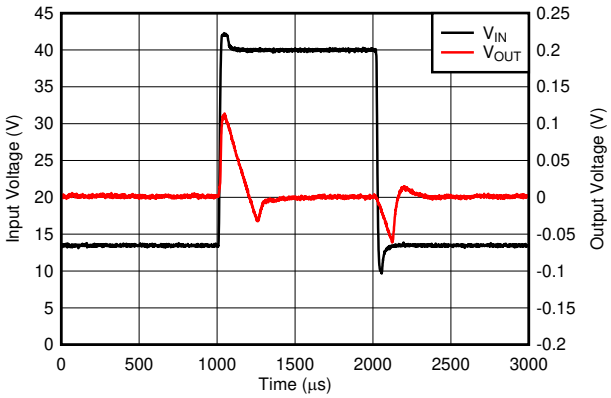
The device has state-of-the-art transient response that allows the output to quickly react to changes in load or line (for example, during cold-crank conditions). Additionally, the device has a novel architecture that minimizes output overshoot when recovering from dropout. During normal operation, the device has a tight DC accuracy of ±1.15% over line, load, and temperature.

The device is available in thermally conductive packaging to allow the parts to efficiently transfer heat to the circuit board.

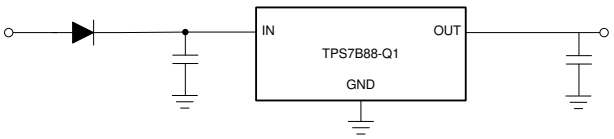
Device Information (1)

PART NUMBER	PACKAGE	BODY SIZE (NOM)
TPS7B88-Q1	TO-252 (3)	6.60 mm × 6.10 mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.



Line Transient Response (3-V/µs V_{IN} Slew Rate)



Output Equal to Reference Voltage

An IMPORTANT NOTICE at the end of this data sheet addresses availability, warranty, changes, use in safety-critical applications, intellectual property matters and other important disclaimers. PRODUCTION DATA.

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4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

DATE	REVISION	NOTES
January 2021	*	Initial Release

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5 Pin Configuration and Functions

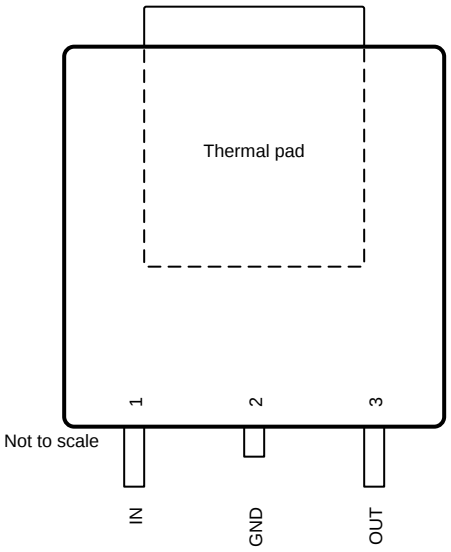

Figure 5-1. KVU Package, 3-Pin TO-252, Top View

Table 5-1. Pin Functions

PIN		TYPE[1]	DESCRIPTION
NAME	KVU		
GND	2	G	Ground pin. Connect this pin to the thermal pad with a low-impedance connection.
IN	1	P	Input power-supply voltage pin. For best transient response and to minimize input impedance, use the recommended value or larger ceramic capacitor from IN to ground as listed in the *Recommended Operating Conditions* table and the *Input Capacitor* section. Place the input capacitor as close to the input of the device as possible
OUT	3	O	Regulated output voltage pin. A capacitor is required from OUT to ground for stability. For best transient response, use the nominal recommended value or larger ceramic capacitor from OUT to ground; see the *Recommended Operating Conditions* table and the *Output Capacitor* section. Place the output capacitor as close to output of the device as possible. If using a high ESR capacitor, decouple the output with a 100-nF ceramic capacitor.
Thermal pad	Pad	—	Connect the thermal pad to a large area GND plane for improved thermal performance.

(1) I = input; O = output; P = power; G = ground.

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6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

		MIN	MAX	UNIT
V_{IN}	Unregulated input	–0.3	42	V
V_{OUT}	Regulated output	–0.3	V_{IN} + 0.3 V(2)	V
T_J	Operating junction temperature	–40	150	°C
T_{stg}	Storage temperature	–65	150	°C

(1) Stresses beyond those listed under *absolute maximum ratings* may cause permanent damage to the device. Theseare stress ratings only and functional operation of the device at these or any other conditionsbeyond those indicated under *recommended operating conditions* isnot implied. Exposure to absolute-maximum-rated conditions for extended periods may affect devicereliability.

(2) The absolute maximum rating is VIN + 0.3 V or 20 V, whichever is smaller

6.2 ESD Ratings

				VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human-body model (HBM), per AEC Q100-002(1)		±2000	V
		Charged-device model (CDM), per AEC Q100-011	All pins	±500	
			Corner pins	±750	

(1) AEC Q100-002 indicates that HBM stressing shall be in accordancewith the ANSI/ESDA/JEDEC JS-001 specification.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	TYP	MAX	UNIT
V_{IN}	Input voltage	3		40	V
V_{OUT}	Output voltage	1.2		18	V
I_{OUT}	Output current	0		500	mA
C_{OUT}	Output capacitor(2)	2.2		220	µF
ESR	Output capacitor ESR requirements	0.001		2	Ω
C_{IN}	Input capacitor(1)	0.1	1		µF
T_J	Operating junction temperature	–40		150	°C

(1) For robust EMI performance the minimum input capacitance is 500 nF.

(2) Effective output capacitance of 1 µF minimum required for stability.

6.4 Thermal Information

THERMAL METRIC(1) (2)		TPS7B88-Q1 KVU 3 PINS	UNIT
$R_{\theta JA}$	Junction-to-ambient thermal resistance	30	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	39.5	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	8.6	°C/W
ψ_{JT}	Junction-to-top characterization parameter	2.6	°C/W
ψ_{JB}	Junction-to-board characterization parameter	8.6	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	1.3	°C/W

(1) The thermal data is based on the JEDEC standard high K profile,JESD 51-7. Two-signal, two-plane, four-layer board with 2-oz. copper. The copper pad is soldered tothe thermal land pattern. Also, correct attachment procedure must be incorporated.

(2) For more information about traditional and new thermal metrics,see the Semiconductor and IC PackageThermal Metrics application report.

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6.5 Electrical Characteristics

specified at T_J = –40°C to +150°C, V_{IN} = 13.5 V, I_{OUT} = 0 mA, C_{OUT} = 2.2 µF, 1 mΩ < C_{OUT} ESR < 2 Ω, C_{IN} = 1 µF typical values are at T_J = 25°C

PARAMETER		Test Conditions		MIN	TYP	MAX	UNIT
V_{OUT}	Regulated output	V_{IN} = V_{OUT} + 1 V to 40 V, I_{OUT} = 100 µA to 450 mA, T_J = 25ºC(1)		–0.85		0.85	%
		V_{IN} = V_{OUT} + 1 V to 40 V, I_{OUT} = 100 µA to 500 mA, T_J = 25ºC(1)		–0.85		0.85	
		V_{IN} = V_{OUT} + 1 V to 40 V, I_{OUT} = 100 µA to 450 mA(1)		–1.15		1.15	
		V_{IN} = V_{OUT} + 1 V to 40 V, I_{OUT} = 100 µA to 500 mA(1)		–1.15		1.15	
$\Delta V_{OUT(\Delta IOUT)}$	Load regulation	V_{IN} = V_{OUT} + 1 V, I_{OUT} = 100 µA to 450 mA , V_{OUT} ≥ 3.3 V				0.425	%
		V_{IN} = V_{OUT} + 1 V, I_{OUT} = 100 µA to 500 mA , V_{OUT} ≥ 3.3 V				0.45	
$\Delta V_{OUT(\Delta VIN)}$	Line regulation	V_{IN} = V_{OUT} + 1 V to 40 V, I_{OUT} = 100 µA				0.2	%
ΔV_{OUT}	Load transient response settling time	t_R = t_F = 1 µs; C_{OUT} = 10 µF, V_{OUT} ≥ 3.3V				100	µs
ΔV_{OUT}	Load transient response overshoot, undershoot(2)	t_R = t_F = 1 µs; C_{OUT} = 10 µF	I_{OUT} = 150 mA to 350 mA	–2%			%V_{OUT}
			I_{OUT} = 350 mA to 150 mA			10%	
			I_{OUT} = 0 mA to 500 mA	–10%			
I_Q	Quiescent current	V_{IN} = V_{OUT} + 1 V to 40V, I_{OUT} = 0 mA, T_J = 25ºC(3)			17	21	µA
		V_{IN} = V_{OUT} + 1 V to 40 V, I_{OUT} = 0 mA(3)				26	
		I_{OUT} = 500 µA				35	
V_{DO}	Dropout voltage fixed output voltages (KVU Package)	I_{OUT} ≤ 1 mA, V_{OUT} ≥ 3.3 V, V_{IN} = $V_{OUT(NOM)}$ x 0.95				46	mV
		I_{OUT} = 315 mA, V_{OUT} ≥ 3.3 V, V_{IN} = $V_{OUT(NOM)}$			275	400	
		I_{OUT} = 450 mA, V_{OUT} ≥ 3.3 V, V_{IN} = $V_{OUT(NOM)}$			360	525	
		I_{OUT} = 500 mA, V_{OUT} ≥ 3.3 V, V_{IN} = $V_{OUT(NOM)}$			390	575	
$V_{UVLO(RISING)}$	Rising input supply UVLO	V_{IN} rising		2.6	2.7	2.82	V
$V_{UVLO(FALLING)}$	Falling input supply UVLO	V_{IN} falling		2.38	2.5	2.6	V
$V_{UVLO(HYST)}$	$V_{UVLO(IN)}$ hysteresis				230		mV
I_{CL}	Output current limit	V_{IN} = V_{OUT} + 1 V, V_{OUT} short to 90% x $V_{OUT(NOM)}$		540		780	mA
PSRR	Power supply rejection ratio	V_{IN} - V_{OUT} = 1 V, frequency = 1 kHz, I_{OUT} = 450 mA			70		dB
T_J	Junction temperature			–40		150	°C
$T_{SD(SHUTDOWN)}$	Junction shutdown temperature				175		°C
$T_{SD(HYST)}$	Hysteresis of thermal shutdown				20		°C

(1) Power dissipation is limited to 2 W for device production testing purposes. The power dissipation can be higher during normal operation. See the thermal dissipation section for more information on how much power the device can dissipate while maintaining a junction temperature below 150°C.

(2) Specified by design.

(3) For the adjustable output this is tested in unity gain and resistor current is not included.

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6.6 Typical Characteristics

specified at T_J = –40°C to +150°C, V_{IN} = 13.5 V, I_{OUT} = 100 µA, C_{OUT} = 2.2 µF, 1 mΩ < C_{OUT} ESR < 2 Ω, C_{IN} = 1 µF (unless otherwise noted)

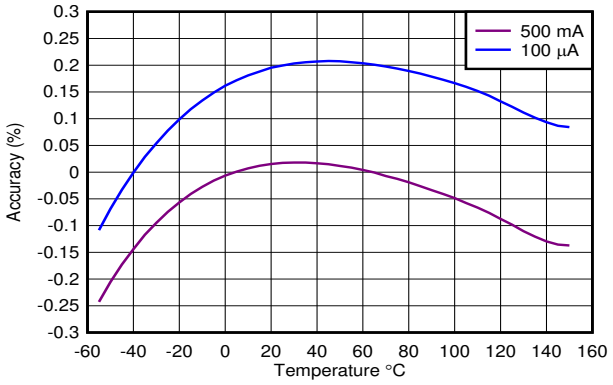
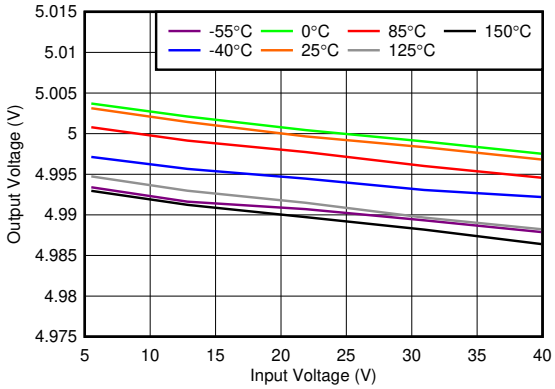
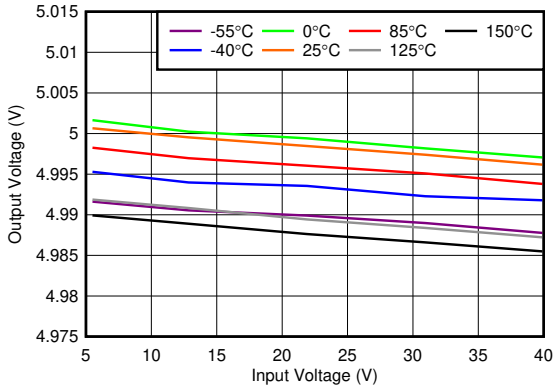


Figure 6-1. Accuracy vs Temperature



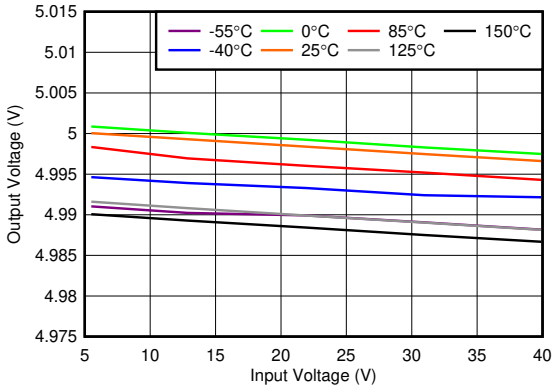
V_{OUT} = 5 V, I_{OUT} = 150 mA

Figure 6-2. Line Regulation vs V_{IN}



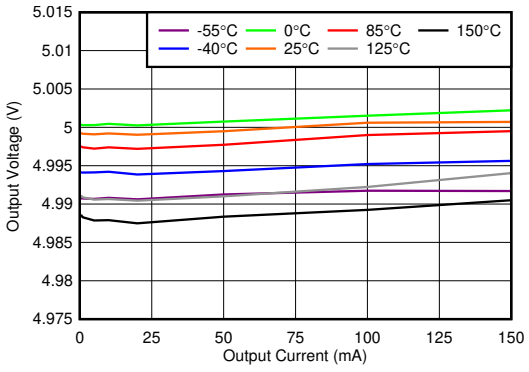
V_{OUT} = 5 V, I_{OUT} = 5 mA

Figure 6-3. Line Regulation vs V_{IN}



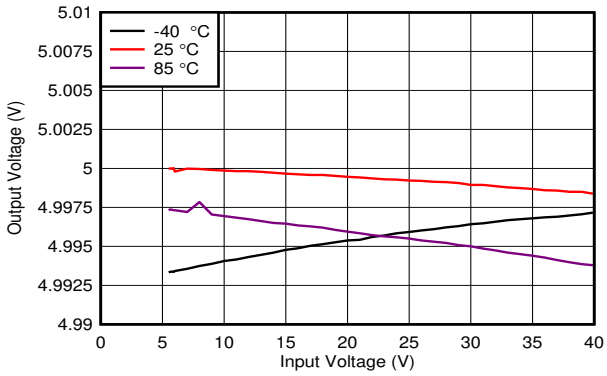
V_{OUT} = 5 V, I_{OUT} = 1 mA

Figure 6-4. Line Regulation vs V_{IN}



V_{OUT} = 5 V

Figure 6-5. Load Regulation vs I_{OUT}



C_{OUT} = 10 µF, V_{OUT} = 5 V

Figure 6-6. Line Regulation at 50 mA

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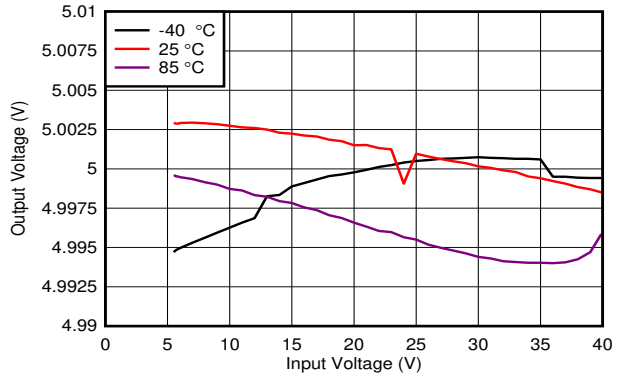
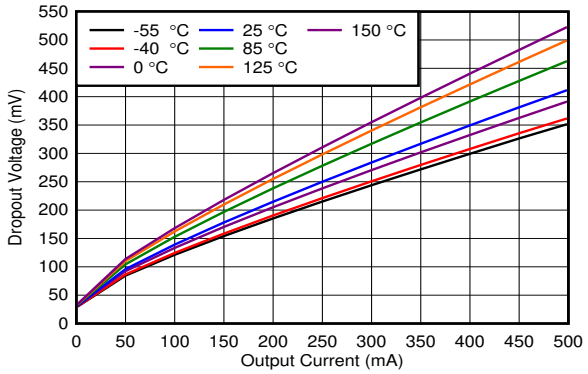
6.6 Typical Characteristics (continued)

specified at T_J = –40°C to +150°C, V_{IN} = 13.5 V, I_{OUT} = 100 µA, C_{OUT} = 2.2 µF, 1 mΩ < C_{OUT} ESR < 2 Ω, C_{IN} = 1 µF (unless otherwise noted)



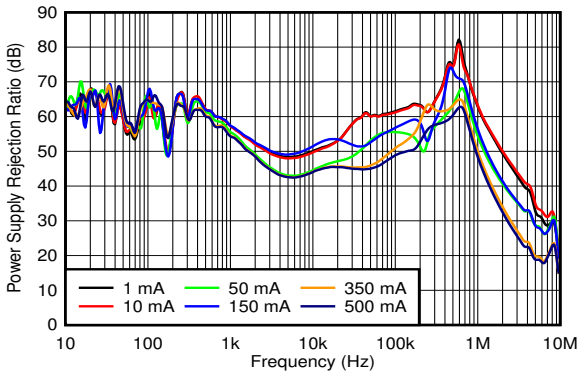
C_{OUT} = 10 µF, V_{OUT} = 5 V

Figure 6-7. Line Regulation at 100 mA



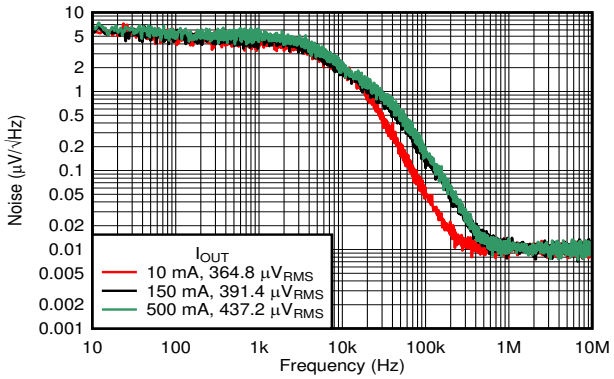
V_{IN} = 3 V

Figure 6-8. Dropout Voltage (V_{DO}) vs I_{OUT}



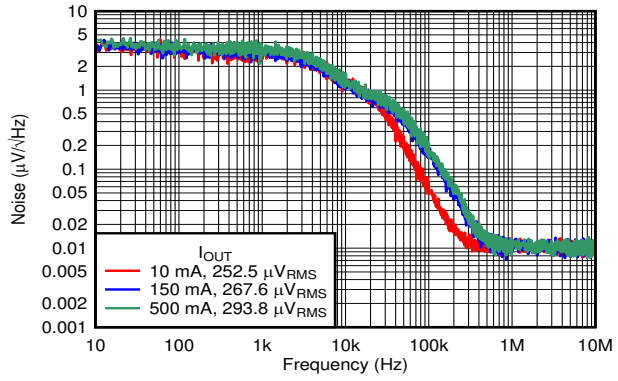
C_{OUT} = 10 µF (X7R 50 V), V_{OUT} = 5 V

Figure 6-9. PSRR vs Frequency and I_{OUT}



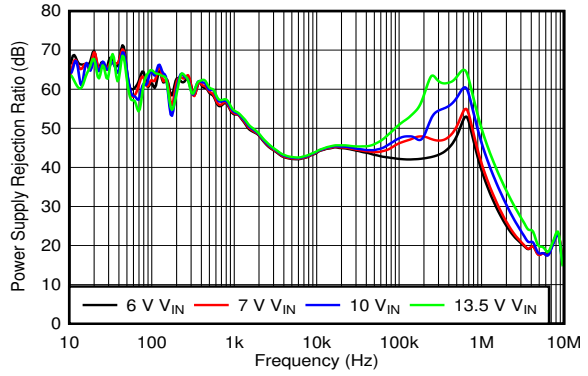
C_{OUT} = 10 µF (X7R 50 V), V_{OUT} = 5 V

Figure 6-10. Noise vs Frequency



C_{OUT} = 10 µF (X7R 50 V), V_{OUT} = 3.3 V

Figure 6-11. Noise vs Frequency



C_{OUT} = 10 µF (X7R 50 V), I_{OUT} = 500 mA, V_{OUT} = 5 V

Figure 6-12. PSRR vs Frequency and V_{IN}

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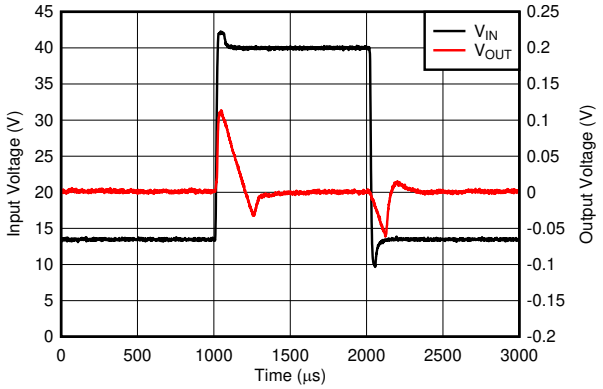
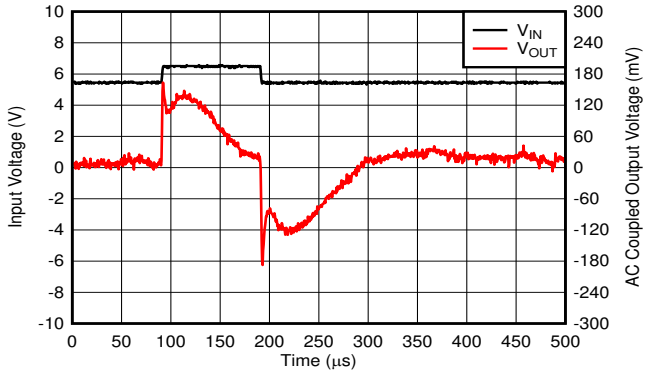
6.6 Typical Characteristics (continued)

specified at T_J = –40°C to +150°C, V_{IN} = 13.5 V, I_{OUT} = 100 µA, C_{OUT} = 2.2 µF, 1 mΩ < C_{OUT} ESR < 2 Ω, C_{IN} = 1 µF (unless otherwise noted)



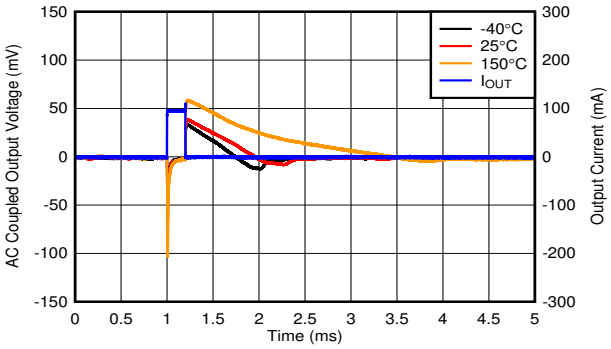
V_{OUT} = 5 V, I_{OUT} = 1 mA, V_{IN} = 13.5 V to 45 V, slew rate = 2.7 V/µs

Figure 6-13. Line Transients



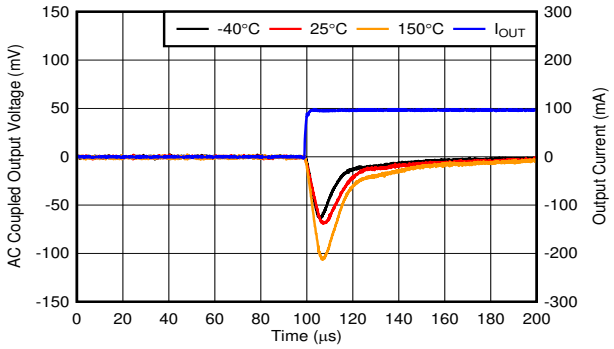
V_{OUT} = 5 V, I_{OUT} = 100 mA, V_{IN} = 5.5 V to 6.5 V, rise time = 1 µs

Figure 6-14. Line Transients



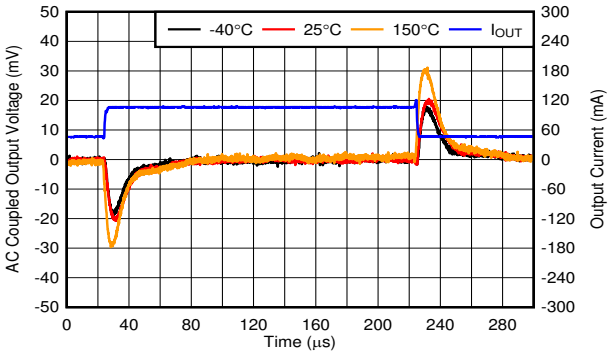
V_{OUT} = 5 V, I_{OUT} = 0 mA to 100 mA, slew rate = 1 A/µs, C_{OUT} = 10 µF

Figure 6-15. Load Transient, No Load to 100 mA



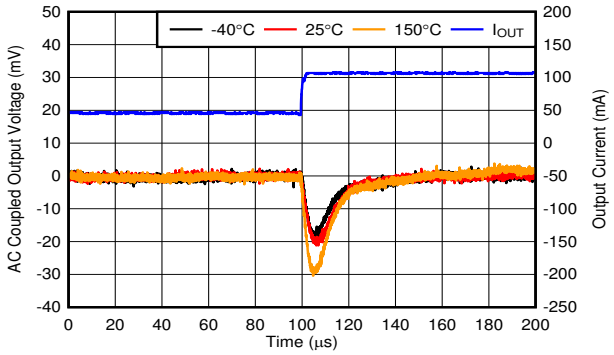
V_{OUT} = 5 V, I_{OUT} = 0 mA to 100 mA, slew rate = 1 A/µs, C_{OUT} = 10 µF

Figure 6-16. Load Transient, No Load to 100-mA Rising Edge



V_{OUT} = 5 V, I_{OUT} = 45 mA to 105 mA, slew rate = 0.1 A/µs, C_{OUT} = 10 µF

Figure 6-17. Load Transient, 45 mA to 105 mA



V_{OUT} = 5 V, I_{OUT} = 45 mA to 105 mA, slew rate = 0.1 A/µs, C_{OUT} = 10 µF

Figure 6-18. Load Transient, 45-mA to 105-mA Rising Edge

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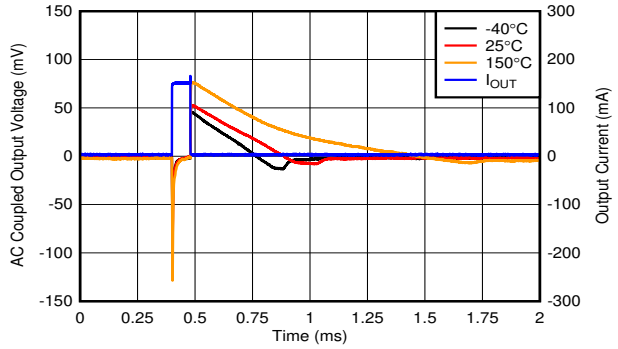
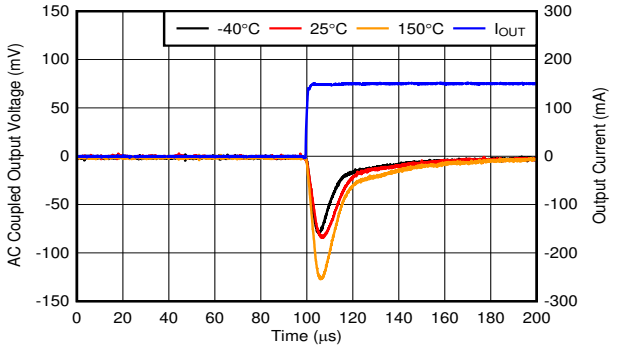
6.6 Typical Characteristics (continued)

specified at T_J = –40°C to +150°C, V_{IN} = 13.5 V, I_{OUT} = 100 µA, C_{OUT} = 2.2 µF, 1 mΩ < C_{OUT} ESR < 2 Ω, C_{IN} = 1 µF (unless otherwise noted)



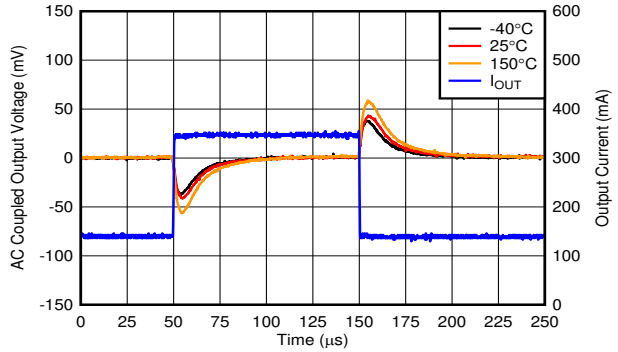
V_{OUT} = 5 V, I_{OUT} = 0 mA to 150 mA, slew rate = 1 A/µs, C_{OUT} = 10 µF

Figure 6-19. Load Transient, No Load to 150-mA



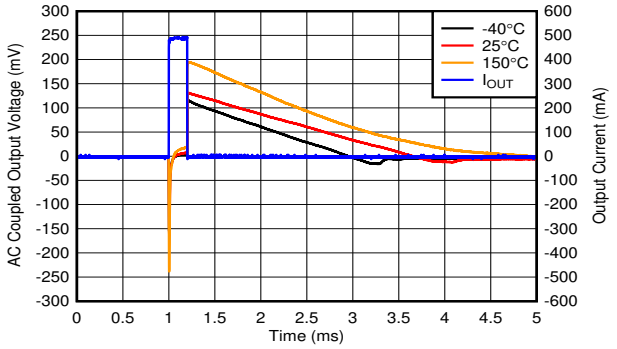
V_{OUT} = 5 V, I_{OUT} = 0 mA to 150 mA, slew rate = 1 A/µs, C_{OUT} = 10 µF

Figure 6-20. Load Transient, No Load to 150-mA Rising Edge



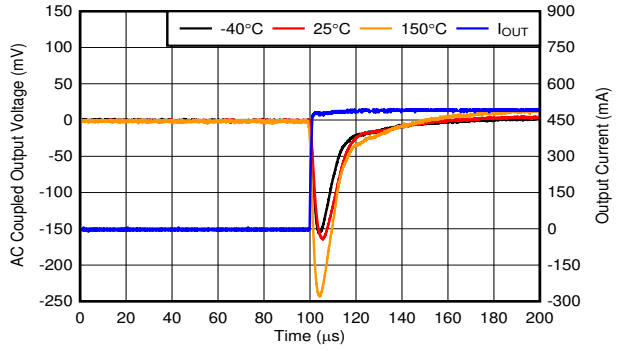
V_{OUT} = 5 V, I_{OUT} = 150 mA to 350 mA, slew rate = 0.1 A/µs, C_{OUT} = 10 µF

Figure 6-21. Load Transient, 150-mA to 350-mA



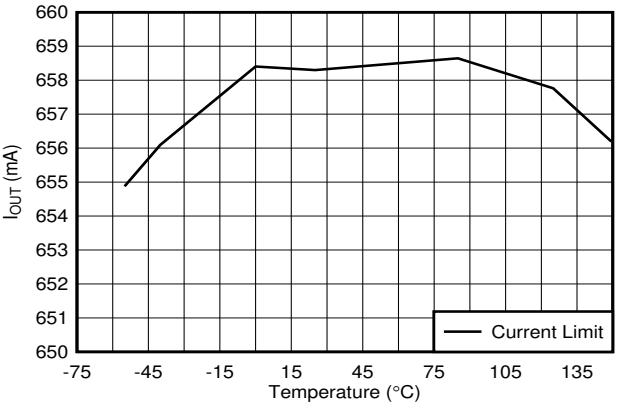
V_{OUT} = 5 V, I_{OUT} = 0 mA to 500 mA, slew rate = 1 A/µs, C_{OUT} = 10 µF

Figure 6-22. Load Transient, No Load to 500 mA



V_{OUT} = 5 V, I_{OUT} = 0 mA to 500 mA, slew rate = 1 A/µs, C_{OUT} = 10 µF

Figure 6-23. Load Transient, No Load to 500-mA Rising Edge



V_{IN} = V_{OUT} + 1 V, V_{OUT} = 90% × $V_{OUT(NOM)}$

Figure 6-24. Output Current Limit vs Temperature

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6.6 Typical Characteristics (continued)

specified at T_J = –40°C to +150°C, V_{IN} = 13.5 V, I_{OUT} = 100 µA, C_{OUT} = 2.2 µF, 1 mΩ < C_{OUT} ESR < 2 Ω, C_{IN} = 1 µF (unless otherwise noted)

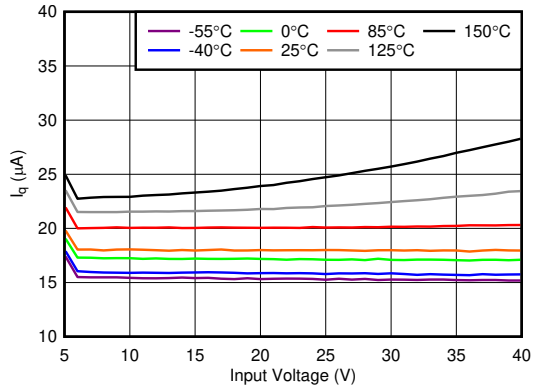
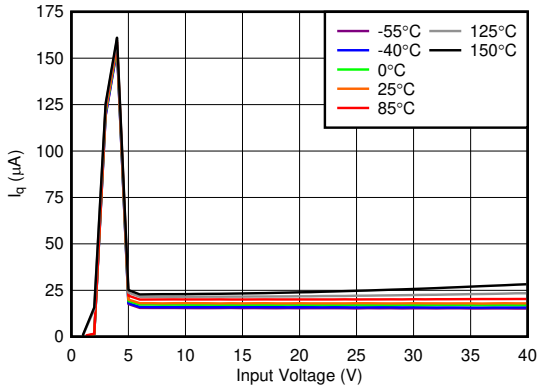


Figure 6-25. Quiescent Current (I_Q) vs V_{IN}



V_{OUT} = 5 V

Figure 6-26. Quiescent Current (I_Q) vs V_{IN}

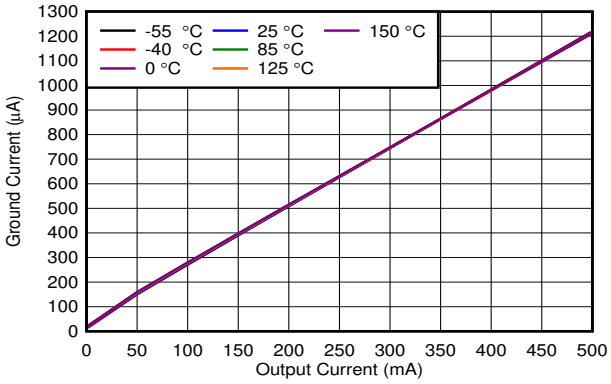


Figure 6-27. Ground Current (I_{GND}) vs I_{OUT}

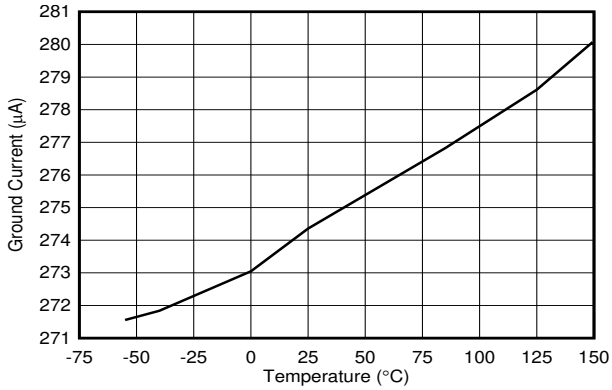


Figure 6-28. Ground Current at 100 mA

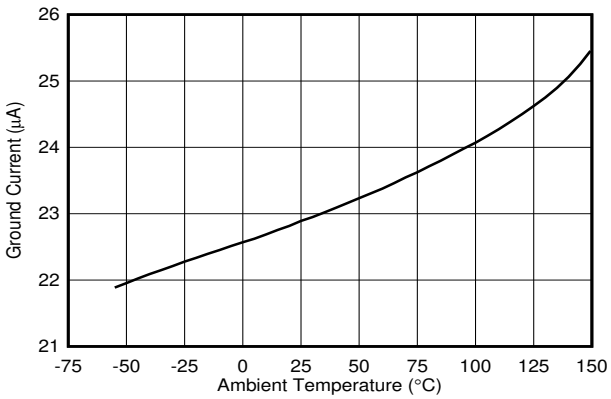
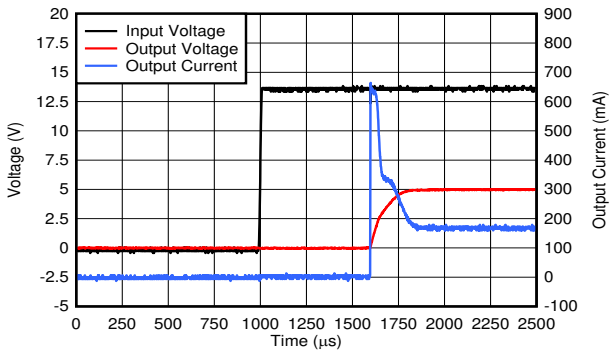


Figure 6-29. Ground Current at 500 µA



V_{IN} = 13.5 V, V_{OUT} = 5 V, I_{OUT} = 150 mA, C_{OUT} = 10 µF

Figure 6-30. Startup Plot Inrush Current

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6.6 Typical Characteristics (continued)

specified at T_J = –40°C to +150°C, V_{IN} = 13.5 V, I_{OUT} = 100 µA, C_{OUT} = 2.2 µF, 1 mΩ < C_{OUT} ESR < 2 Ω, C_{IN} = 1 µF (unless otherwise noted)

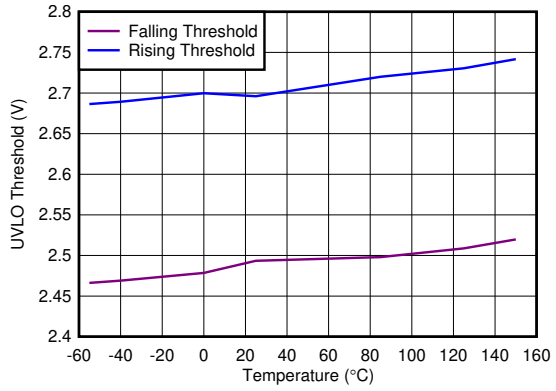

Figure 6-31. Undervoltage Lockout (UVLO) Threshold vs Temperature

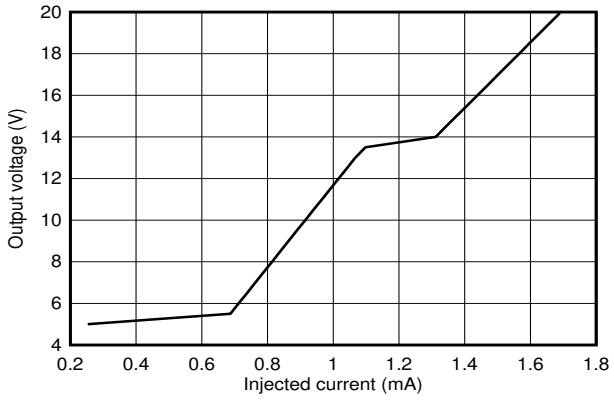

Figure 6-32. Output Voltage vs Injected Current

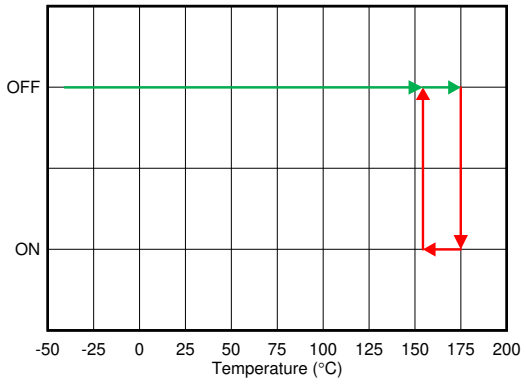

Figure 6-33. Thermal Shutdown

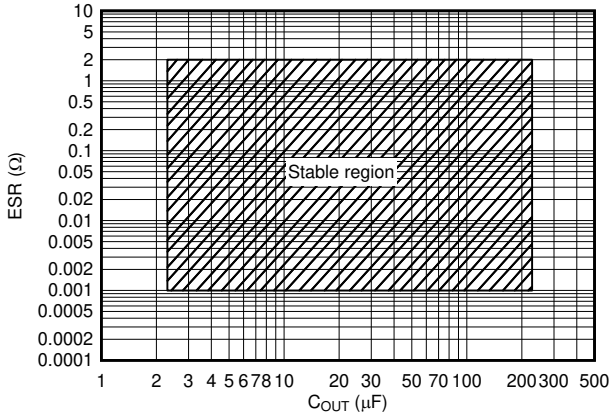

Figure 6-34. Stability, ESR vs C_{OUT}

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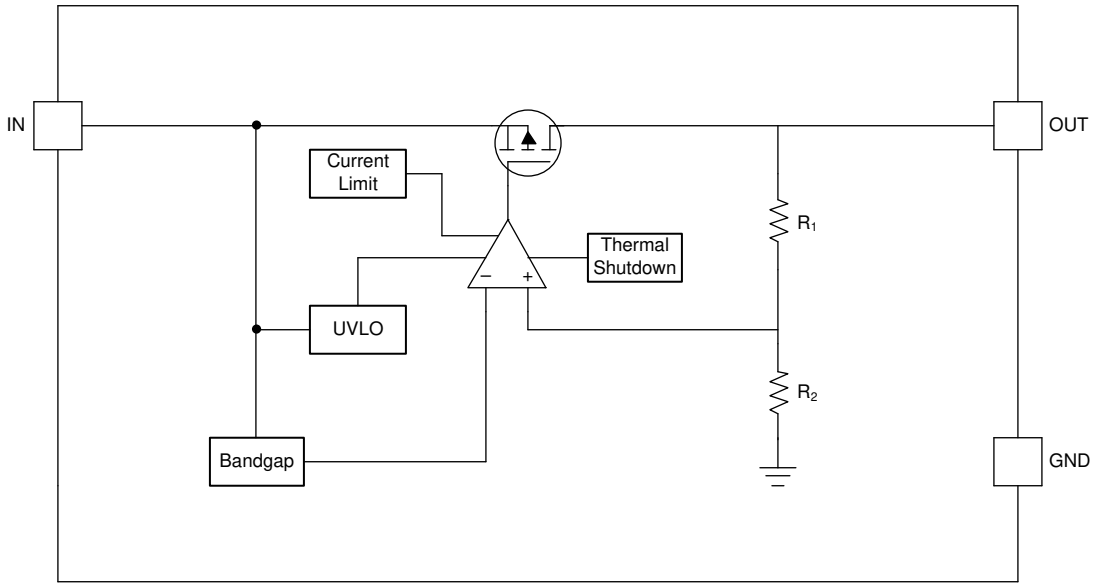
7 Detailed Description

7.1 Overview

The TPS7B88-Q1 is a low-dropout linear regulator (LDO) with improved transient performance that allows for quick response to changes in line or load conditions. The device aslo features a novel output overshoot reduction feature that minimizes output overshoot during cold-crank conditions.

During normal operation, the device has a tight DC accuracy of ±1.15% over line, load, and temperature. The increased accuracy allows for the powering of sensitive analog loads or sensors.

7.2 Functional Block Diagram



7.3 Feature Description

7.3.1 Undervoltage Lockout

The device has an independent undervoltage lockout (UVLO) circuit that monitors the input voltage, allowing a controlled and consistent turn on and off of the output voltage. To prevent the device from turning off if the input drops during turn on, the UVLO has hysteresis as specified in the *Electrical Characteristics* table.

7.3.2 Thermal Shutdown

The device contains a thermal shutdown protection circuit to disable the device when the junction temperature (T_J) of the pass transistor rises to $T_{SD(shutdown)}$ (typical). Thermal shutdown hysteresis assures that the device resets (turns on) when the temperature falls to $T_{SD(reset)}$ (typical).

The thermal time-constant of the semiconductor die is fairly short, thus the device may cycle on and off when thermal shutdown is reached until power dissipation is reduced. Power dissipation during startup can be high from large $V_{IN} – V_{OUT}$ voltage drops across the device or from high inrush currents charging large output capacitors. Under some conditions, the thermal shutdown protection disables the device before startup completes.

For reliable operation, limit the junction temperature to the maximum listed in the *Recommended Operating Conditions* table. Operation above this maximum temperature causes the device to exceed its operational specifications. Although the internal protection circuitry of the device is designed to protect against thermal overall conditions, this circuitry is not intended to replace proper heat sinking. Continuously running the device into thermal shutdown or above the maximum recommended junction temperature reduces long-term reliability.

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7.3.3 Current Limit

The device has an internal current limit circuit that protects the regulator during transient high-load current faults or shorting events. The current limit is a brickwall scheme. In a high-load current fault, the brickwall scheme limits the output current to the current limit (I_{CL}). I_{CL} is listed in the *Electrical Characteristics* table.

The output voltage is not regulated when the device is in current limit. When a current limit event occurs, the device begins to heat up because of the increase in power dissipation. When the device is in brickwall current limit, the pass transistor dissipates power [(V_{IN} – V_{OUT}) × I_{CL}]. If thermal shutdown is triggered, the device turns off. After the device cools down, the internal thermal shutdown circuit turns the device back on. If the output current fault condition continues, the device cycles between current limit and thermal shutdown. For more information on current limits, see the *Know Your Limits* application report.

Figure 7-1 shows a diagram of the current limit.

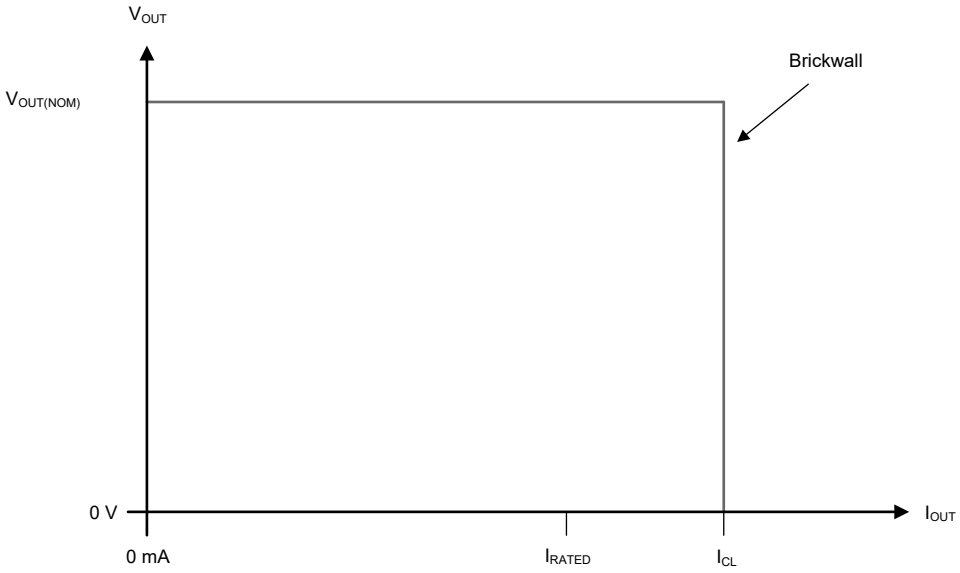

Figure 7-1. Current Limit

7.4 Device Functional Modes

7.4.1 Device Functional Mode Comparison

The *Device Functional Mode Comparison* table shows the conditions that lead to the different modes of operation. See the *Electrical Characteristics* table for parameter values.

Table 7-1. Device Functional Mode Comparison

OPERATING MODE	PARAMETER		
	V_{IN}	I_{OUT}	T_J
Normal operation	$V_{IN} > V_{OUT(nom)} + V_{DO}$ and $V_{IN} > V_{IN(min)}$	$I_{OUT} < I_{OUT(max)}$	$T_J < T_{SD(shutdown)}$
Dropout operation	$V_{IN(min)} < V_{IN} < V_{OUT(nom)} + V_{DO}$	$I_{OUT} < I_{OUT(max)}$	$T_J < T_{SD(shutdown)}$
Disabled (any true condition disables the device)	$V_{IN} < V_{UVLO}$	Not applicable	$T_J > T_{SD(shutdown)}$

7.4.2 Normal Operation

The device regulates to the nominal output voltage when the following conditions are met:

- The input voltage is greater than the nominal output voltage plus the dropout voltage ($V_{OUT(nom)} + V_{DO}$)
- The output current is less than the current limit ($I_{OUT} < I_{CL}$)
- The device junction temperature is less than the thermal shutdown temperature ($T_J < T_{SD}$)

7.4.3 Dropout Operation

If the input voltage is lower than the nominal output voltage plus the specified dropout voltage, but all other conditions are met for normal operation, the device operates in dropout mode. In this mode, the output voltage tracks the input voltage. During this mode, the transient performance of the device becomes significantly degraded because the pass transistor is in the ohmic or triode region, and acts as a switch. Line or load transients in dropout can result in large output-voltage deviations.

When the device is in a steady dropout state (defined as when the device is in dropout, $V_{IN} < V_{OUT(NOM)} + V_{DO}$, directly after being in a normal regulation state, but *not* during startup), the pass transistor is driven into the ohmic or triode region. When the input voltage returns to a value greater than or equal to the nominal output voltage plus the dropout voltage ($V_{OUT(NOM)} + V_{DO}$), the output voltage can overshoot for a short period of time while the device pulls the pass transistor back into the linear region.

7.4.4 Disabled

The output of the device can be shutdown by forcing the input voltage below the UVLO falling threshold (see the *Electrical Characteristics* table). When disabled, the pass transistor is turned off and internal circuits are shutdown.

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8 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

8.1 Application Information

8.1.1 Input and Output Capacitor Selection

The TPS7B88-Q1 requires an output capacitor of 2.2 µF or larger (1 µF or larger capacitance) for stability and an equivalent series resistance (ESR) between 0.001 Ω and 2 Ω. For best transient performance, use X5R- and X7R-type ceramic capacitors because these capacitors have minimal variation in value and ESR over temperature. When choosing a capacitor for a specific application, be mindful of the DC bias characteristics for the capacitor. Higher output voltages cause a significant derating of the capacitor. For best performance, the maximum recommended output capacitance is 220 µF.

Although an input capacitor is not required for stability, good analog design practice is to connect a capacitor from IN to GND. Some input supplies have a high impedance, thus placing the input capacitor on the input supply helps reduce the input impedance. This capacitor counteracts reactive input sources and improves transient response, input ripple, and PSRR. If the input supply has a high impedance over a large range of frequencies, several input capacitors can be used in parallel to lower the impedance over frequency. Use a higher-value capacitor if large, fast, rise-time load transients are anticipated, or if the device is located several inches from the input power source.

8.1.2 Dropout Voltage

Dropout voltage (V_{DO}) is defined as the input voltage minus the output voltage ($V_{IN} – V_{OUT}$) at the rated output current (I_{RATED}), where the pass transistor is fully on. I_{RATED} is the maximum I_{OUT} listed in the *Recommended Operating Conditions* table. The pass transistor is in the ohmic or triode region of operation, and acts as a switch. The dropout voltage indirectly specifies a minimum input voltage greater than the nominal programmed output voltage at which the output voltage is expected to stay in regulation. If the input voltage falls to less than the nominal output regulation, then the output voltage falls as well.

For a CMOS regulator, the dropout voltage is determined by the drain-source on-state resistance ($R_{DS(ON)}$) of the pass transistor. Therefore, if the linear regulator operates at less than the rated current, the dropout voltage for that current scales accordingly. The following equation calculates the $R_{DS(ON)}$ of the device.

$$R_{DS(ON)} = \frac{V_{DO}}{I_{RATED}} \quad (1)$$

8.1.3 Reverse Current

Excessive reverse current can damage this device. Reverse current flows through the intrinsic body diode of the pass transistor instead of the normal conducting channel. At high magnitudes, this current flow degrades the long-term reliability of the device.

Conditions where reverse current can occur are outlined in this section, all of which can exceed the absolute maximum rating of $V_{OUT} \leq V_{IN} + 0.3$ V.

- If the device has a large C_{OUT} and the input supply collapses with little or no load current
- The output is biased when the input supply is not established
- The output is biased above the input supply

If reverse current flow is expected in the application, external protection is recommended to protect the device. Reverse current is not limited in the device, so external limiting is required if extended reverse voltage operation is anticipated.

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8.1.4 Power Dissipation (P_D)

Circuit reliability requires consideration of the device power dissipation, location of the circuit on the printed circuit board (PCB), and correct sizing of the thermal plane. The PCB area around the regulator must have few or no other heat-generating devices that cause added thermal stress.

To first-order approximation, power dissipation in the regulator depends on the input-to-output voltage difference and load conditions. The following equation calculates power dissipation (P_D).

$$P_D = (V_{IN} – V_{OUT}) \times I_{OUT} \quad (2)$$

Note

Power dissipation can be minimized, and therefore greater efficiency can be achieved, by correct selection of the system voltage rails. For the lowest power dissipation use the minimum input voltage required for correct output regulation.

For devices with a thermal pad, the primary heat conduction path for the device package is through the thermal pad to the PCB. Solder the thermal pad to a copper pad area under the device. This pad area must contain an array of plated vias that conduct heat to additional copper planes for increased heat dissipation.

The maximum power dissipation determines the maximum allowable ambient temperature (T_A) for the device. According to the following equation, power dissipation and junction temperature are most often related by the junction-to-ambient thermal resistance ($R_{\theta JA}$) of the combined PCB and device package and the temperature of the ambient air (T_A).

$$T_J = T_A + (R_{\theta JA} \times P_D) \quad (3)$$

Thermal resistance ($R_{\theta JA}$) is highly dependent on the heat-spreading capability built into the particular PCB design, and therefore varies according to the total copper area, copper weight, and location of the planes. The junction-to-ambient thermal resistance listed in the *Thermal Information* table is determined by the JEDEC standard PCB and copper-spreading area, and is used as a relative measure of package thermal performance.

8.1.4.1 Power Dissipation Versus Ambient Temperature

Figure 8-1 is based off of a JESD51-7 4-layer, high-K board. The allowable power dissipation was estimated using the following equation. As disscussed in the *An empirical analysis of the impact of board layout on LDO thermal performance* application report, thermal dissipation can be improved in the JEDEC high-K layout by adding top layer copper and increasing the number of thermal vias. If a good thermal layout is used, the allowable thermal dissipation can be improved by up to 50%.

$$T_A + R_{\theta JA}\, x\, P_D \leq 150\,°C \quad (4)$$

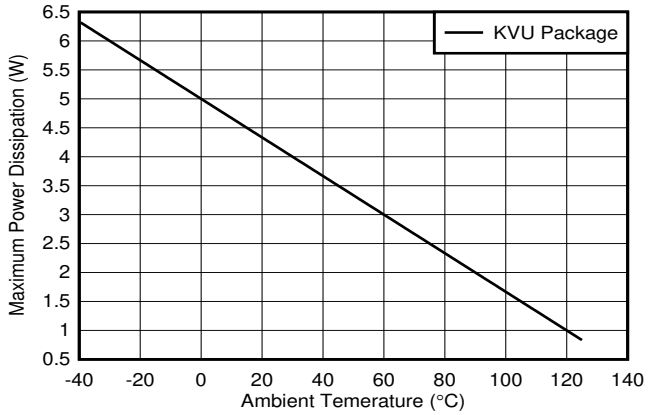

Figure 8-1. TPS7B88-Q1 Allowable Power Dissipation

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8.1.5 Estimating Junction Temperature

The JEDEC standard now recommends the use of psi (Ψ) thermal metrics to estimate the junction temperatures of the linear regulator when in-circuit on a typical PCB board application. These metrics are not thermal resistance parameters and instead offer a practical and relative way to estimate junction temperature. These psi metrics are determined to be significantly independent of the copper area available for heat-spreading. The *Thermal Information* table lists the primary thermal metrics, which are the junction-to-top characterization parameter (ψ_{JT}) and junction-to-board characterization parameter (ψ_{JB}). These parameters provide two methods for calculating the junction temperature (T_J), as described in the following equations. Use the junction-to-top characterization parameter (ψ_{JT}) with the temperature at the center-top of device package (T_T) to calculate the junction temperature. Use the junction-to-board characterization parameter (ψ_{JB}) with the PCB surface temperature 1 mm from the device package (T_B) to calculate the junction temperature.

$$T_J = T_T + \psi_{JT} \times P_D \quad (5)$$

where:

- P_D is the dissipated power
- T_T is the temperature at the center-top of the device package

$$T_J = T_B + \psi_{JB} \times P_D \quad (6)$$

where

- T_B is the PCB surface temperature measured 1 mm from the device package and centered on the package edge

For detailed information on the thermal metrics and how to use them, see the *Semiconductor and IC Package Thermal Metrics* application report.

8.2 Typical Application

Figure 8-2 shows a typical application circuit for the TPS7B88-Q1. TI recommends a low-ESR ceramic capacitor with a dielectric of type X5R or X7R.

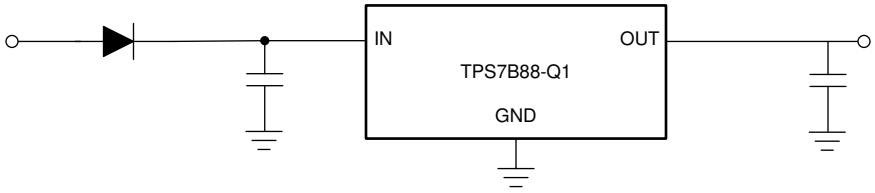

Figure 8-2. Typical Application Schematic for the TPS7B88-Q1

8.2.1 Design Requirements

For this design example, use the parameters listed in Table 8-1 as the input parameters.

Table 8-1. Design Parameters

DESIGN PARAMETER	EXAMPLE VALUE
Input voltage range	6 V to 40 V
Output voltage	5 V
Output current	350 mA
Output capacitor	10 µF

8.2.2 Detailed Design Procedure

8.2.2.1 Input Capacitor

The device requires an input decoupling capacitor, the value of which depends on the application. The typical recommended value for the decoupling capacitor is 1 µF. The voltage rating must be greater than the maximum input voltage.

8.2.2.2 Output Capacitor

The device requires an output capacitor to stabilize the output voltage. The capacitor value must be between 2.2 µF and 200 µF and the ESR range must be between 1 mΩ and 2 Ω. For this design, a low ESR, 10-µF ceramic capacitor was used to improve transient performance.

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8.2.3 Application Curves

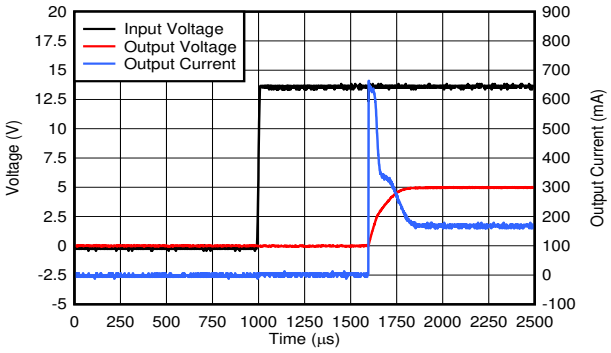

Figure 8-3. Power-Up Waveform

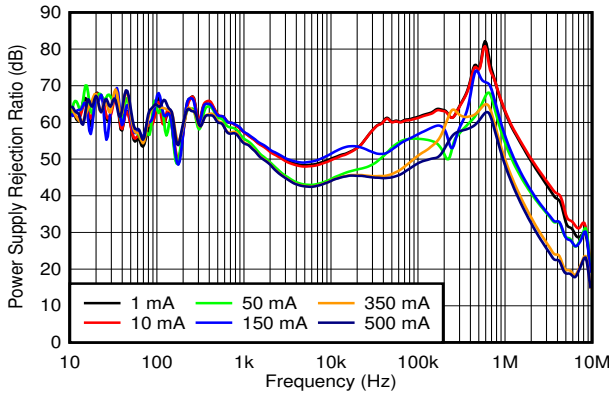

Figure 8-4. PSRR

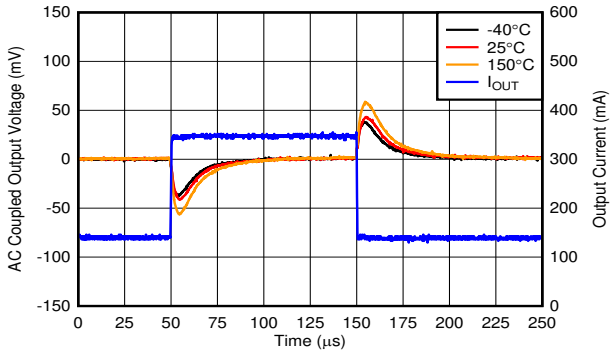

Figure 8-5. Transient Response

9 Power Supply Recommendations

This device is designed for operation from an input voltage supply with a range between 3 V and 40 V. This input supply must be well regulated. If the input supply is located more than a few inches from the TPS7B88-Q1, add an electrolytic capacitor with a value of 22 µF and a ceramic bypass capacitor at the input.

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10 Layout

10.1 Layout Guidelines

For best overall performance, place all circuit components on the same side of the circuit board and as near as practical to the respective LDO pin connections. Place ground return connections to the input and output capacitor, and to the LDO ground pin as close as possible to each other, connected by a wide, component-side, copper surface. The use of vias and long traces to the input and output capacitors is strongly discouraged and negatively affects system performance. TI also recommends a ground reference plane either embedded in the PCB itself or located on the bottom side of the PCB opposite the components. This reference plane serves to assure accuracy of the output voltage, shield noise, and behaves similarly to a thermal plane to spread (or sink) heat from the LDO device when connected to the thermal pad. In most applications, this ground plane is necessary to meet thermal requirements.

10.1.1 Package Mounting

Solder pad footprint recommendations for the TPS7B88-Q1 are available at the end of this document and at www.ti.com.

10.1.2 Board Layout Recommendations to Improve PSRR and Noise Performance

As depicted in Figure 10-1 , place the input and output capacitors close to the device for the layout of the TPS7B88-Q1. In order to enhance the thermal performance, place as many vias as possible around the device. These vias improve the heat transfer between the different GND planes in the PCB.

To improve AC performance such as PSRR, output noise, and transient response, TI recommends a board design with separate ground planes for V_{IN} and V_{OUT}, with each ground plane connected only at the GND pin of the device. In addition, the ground connection for the output capacitor must connect directly to the GND pin of the device.

Minimize equivalent series inductance (ESL) and ESR in order to maximize performance and ensure stability. Place each capacitor as close as possible to the device and on the same side of the PCB as the regulator itself.

Do not place any of the capacitors on the opposite side of the PCB from where the regulator is installed. TI strongly discourages the use of vias and long traces to connect the capacitors because may negatively affect system performance and even cause instability.

If possible, and to ensure the maximum performance specified in this document, use the same layout pattern used for the TPS7B88-Q1 evaluation board, available at www.ti.com.

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10.2 Layout Example

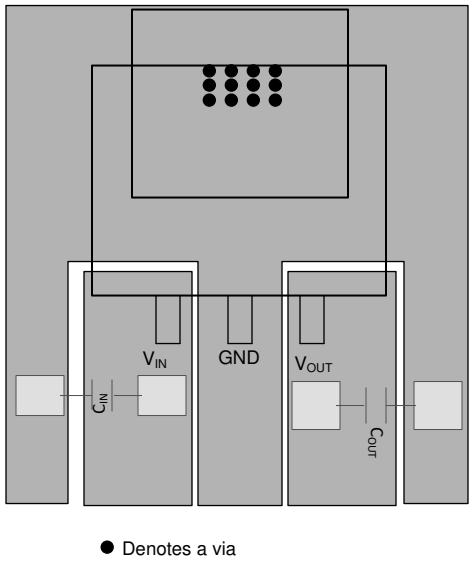

Figure 10-1. KVU Package Fixed Output

11 Device and Documentation Support

11.1 Device Support

11.1.1 Device Nomenclature

Table 11-1. Device Nomenclature (1)

PRODUCT	V_{OUT}
TPS7B88**xx**QKVURQ1	**xx** is the nominal output voltage (for example, 33 = 3.3 V V; 50 = 5.0 V). **Q** indicates that this device is a grade-1 device in accordance with the AEC-Q100 standard. **Q1** indicates that this device is an automotive grade (AEC-Q100) device.

(1) For the most current package and ordering information see the Package Option Addendum at the end of this document, or visit the device product folder on www.ti.com.

11.1.2 Development Support

For the PSpice model, see the TPS7B4250 PSpice Transient Model.

11.2 Documentation Support

11.2.1 Related Documentation

For related documentation see the following:

- Texas Instruments, *Various Applications for Voltage-Tracking LDO* application report
- Texas Instruments, *TPS7B4250 Evaluation Module* user's guide
- Texas Instruments, *TPS7B5250-Q1 Pin FMEA* application report

11.3 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

11.4 Support Resources

TI E2E™ support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

11.5 Trademarks

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All trademarks are the property of their respective owners.

11.6 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

11.7 Glossary

TI Glossary This glossary lists and explains terms, acronyms, and definitions.

12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package | Pins	Package qty | Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
TPS7B8833QKVURQ1	Active	Production	TO-252 (KVU) | 3	2500 | LARGE T&R	Yes	SN	Level-3-260C-168 HR	-40 to 125	7B8833
TPS7B8833QKVURQ1.A	Active	Production	TO-252 (KVU) | 3	2500 | LARGE T&R	Yes	SN	Level-3-260C-168 HR	-40 to 125	7B8833
TPS7B8833QKVURQ1R2	Active	Production	TO-252 (KVU) | 3	2500 | LARGE T&R	Yes	SN	Level-3-260C-168 HR	-40 to 150	7B8833
TPS7B8833QKVURQ1R2.A	Active	Production	TO-252 (KVU) | 3	2500 | LARGE T&R	Yes	SN	Level-3-260C-168 HR	-40 to 150	7B8833
TPS7B8850QKVURQ1	Active	Production	TO-252 (KVU) | 3	2500 | LARGE T&R	Yes	SN	Level-3-260C-168 HR	-40 to 125	7B8850
TPS7B8850QKVURQ1.A	Active	Production	TO-252 (KVU) | 3	2500 | LARGE T&R	Yes	SN	Level-3-260C-168 HR	-40 to 125	7B8850
TPS7B8850QKVURQ1R2	Active	Production	TO-252 (KVU) | 3	2500 | LARGE T&R	Yes	SN	Level-3-260C-168 HR	-40 to 150	7B8850
TPS7B8850QKVURQ1R2.A	Active	Production	TO-252 (KVU) | 3	2500 | LARGE T&R	Yes	SN	Level-3-260C-168 HR	-40 to 150	7B8850

(1) **Status:** For more details on status, see our product life cycle.

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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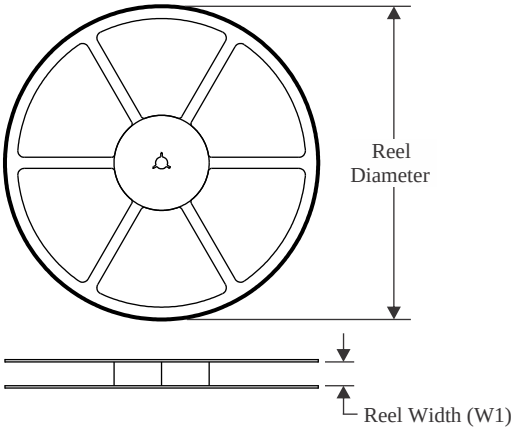
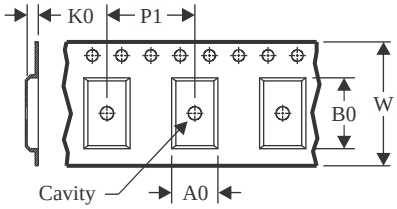
TAPE AND REEL INFORMATION

REEL DIMENSIONS

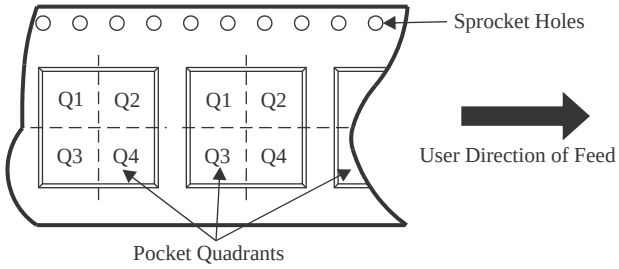


TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

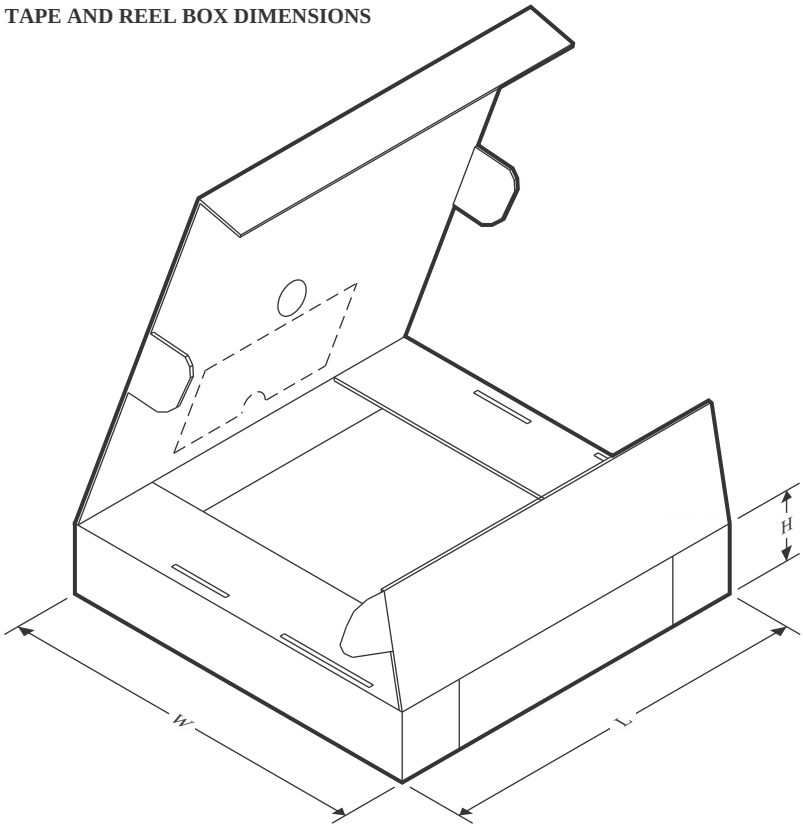
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TPS7B8833QKVURQ1	TO-252	KVU	3	2500	330.0	16.4	6.9	10.5	2.7	8.0	16.0	Q3
TPS7B8833QKVURQ1R2	TO-252	KVU	3	2500	330.0	16.4	6.9	10.5	2.7	8.0	16.0	Q2
TPS7B8850QKVURQ1	TO-252	KVU	3	2500	330.0	16.4	6.9	10.5	2.7	8.0	16.0	Q3
TPS7B8850QKVURQ1R2	TO-252	KVU	3	2500	330.0	16.4	6.9	10.5	2.7	8.0	16.0	Q2

TAPE AND REEL BOX DIMENSIONS



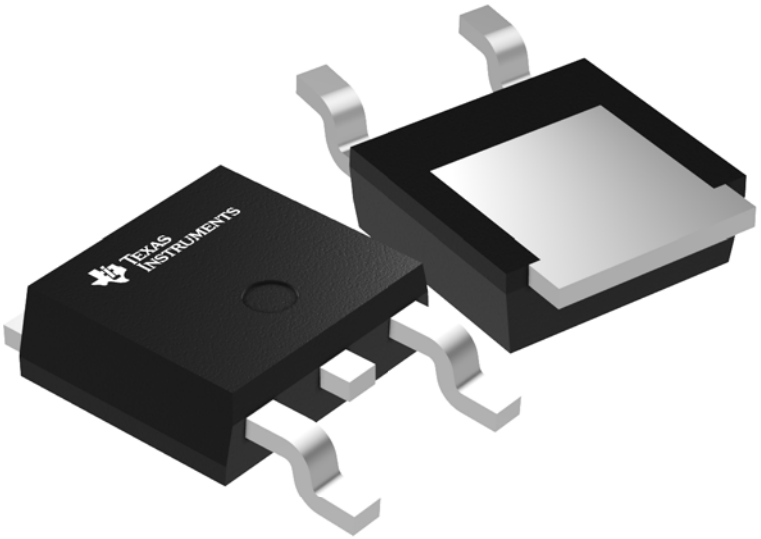
*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TPS7B8833QKVURQ1	TO-252	KVU	3	2500	340.0	340.0	38.0
TPS7B8833QKVURQ1R2	TO-252	KVU	3	2500	340.0	340.0	38.0
TPS7B8850QKVURQ1	TO-252	KVU	3	2500	340.0	340.0	38.0
TPS7B8850QKVURQ1R2	TO-252	KVU	3	2500	340.0	340.0	38.0

KVU 3

TO-252 - 2.52 mm max height

TRANSISTOR OUTLINE



Images above are just a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.

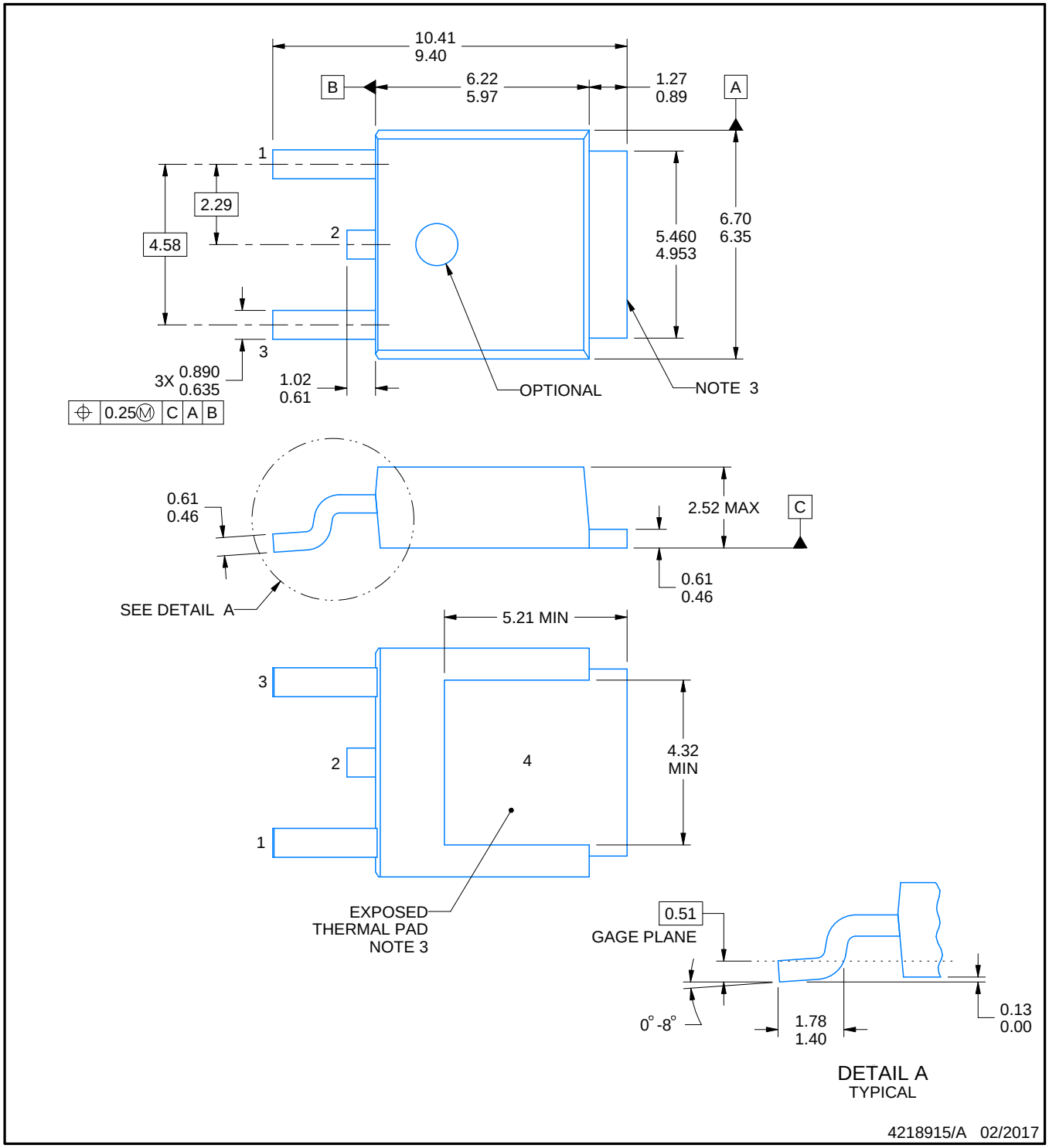


PACKAGE OUTLINE

KVU0003A

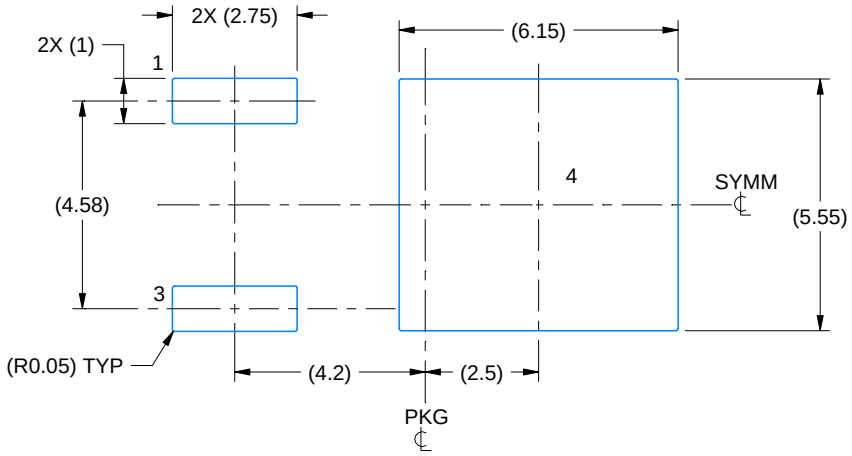
TO-252 - 2.52 mm max height

TO-252

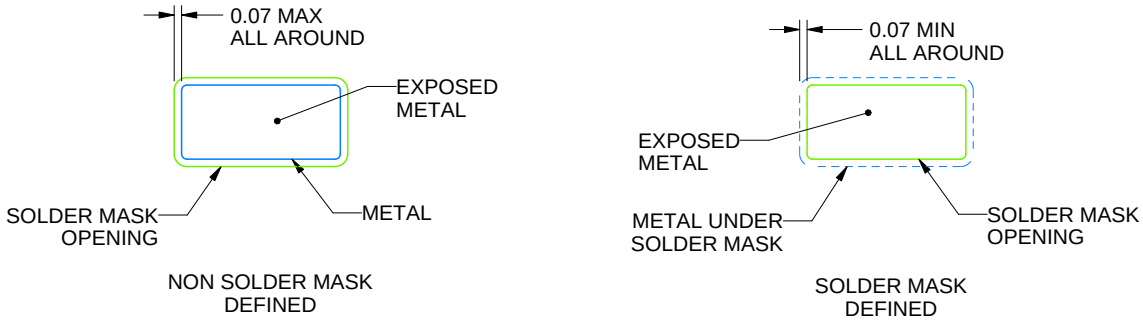


NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. Shape may vary per different assembly sites.
4. Reference JEDEC registration TO-252.



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:6X



SOLDER MASK DETAILS
NOT TO SCALE

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NOTES: (continued)

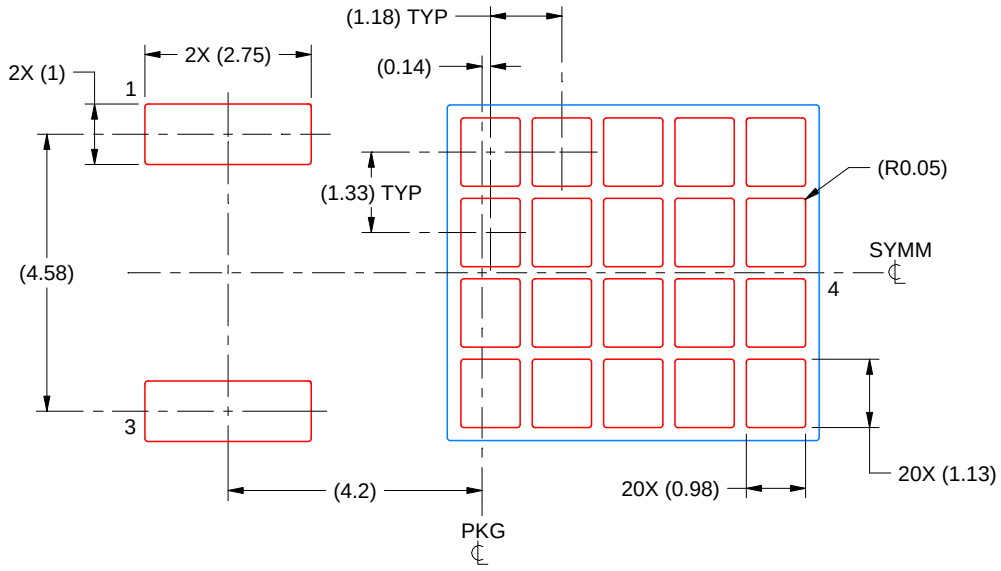
5. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature numbers SLMA002(www.ti.com/lit/slm002) and SLMA004 (www.ti.com/lit/slma004).
6. Vias are optional depending on application, refer to device data sheet. It is recommended that vias under paste be filled, plugged or tented.

EXAMPLE STENCIL DESIGN

KVU0003A

TO-252 - 2.52 mm max height

TO-252



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD
65% PRINTED SOLDER COVERAGE BY AREA
SCALE:8X

4218915/A 02/2017

NOTES: (continued)

7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
8. Board assembly site may have different recommendations for stencil design.

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